

Notice of References Cited	Application/Control No. 10/699,048		Applicant(s)/Patent Under Reexamination VANCE, SCOTT L.	
	Examiner Leith A. Al-Nazer		Art Unit 2821	Page 1 of 2

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2005/0024272 A1	02-2005	Ponce De Leon et al.	343/702
*	B	US-2004/0212545 A1	10-2004	Li et al.	343/866
*	C	US-2004/0207559 A1	10-2004	Milosavljevic, Zlatoljub	343/702
*	D	US-2004/0198293 A1	10-2004	Sadler et al.	455/280
*	E	US-2003/0098812 A1	05-2003	Ying et al.	343/702
*	F	US-2002/0075187 A1	06-2002	McKivergan, Patrick D.	343/702
*	G	US-2002/0070902 A1	06-2002	Johnson et al.	343/702
*	H	US-2001/0050643	12-2001	Egorov et al.	343/702
*	I	US-2001/0048391	12-2001	Annamaa et al.	343/700.0MS
*	J	US-6,876,329 B2	04-2005	Milosavljevic, Zlatoljub	343/700MS
*	K	US-6,831,607 B2	12-2004	Hebron et al.	343/700MS
*	L	US-6,788,257 B2	09-2004	Fang et al.	343/700MS
*	M	US-6,759,989 B2	07-2004	Tarvas et al.	343/700MS

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
*	N	EP 1 351 334 A1	04-2003	Europe	Tan et al.	H01Q 9/04
*	O	EP 1 128 466 A2	01-2001	Europe	Annamaa et al.	H01Q 9/04
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,734,825 B1	05-2004	Guo et al.	343/700MS
*	B	US-6,639,560 B1	10-2003	Kadambi et al.	343/700MS
*	C	US-6,573,869 B2	06-2003	Moore, Thomas G.	343/702
*	D	US-6,552,686 B2	04-2003	Ollikainen et al.	343/700MS
*	E	US-6,456,249 B1	09-2002	Johnson et al.	343/702
*	F	US-6,429,818 B1	08-2002	Johnson et al.	343/702
*	G	US-6,166,694 A	12-2000	Ying, Zhinong	343/702
*	H	US-2003/0160728	08-2003	Fukushima et al.	343/702
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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	N					
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